

Search Notes

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Examiner

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Applicant(s)/Patent under
Reexamination

MOTONARI ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	693	4/7/2006	BT
438	695	4/7/2006	BT
438	697	4/7/2006	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	693	4/7/2006	BT
438	695	4/7/2006	BT
438	697	4/7/2006	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	4/7/2006	BT